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JC07 Rec'd PCT/PTO 3 1 JAN 2002

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Toshikazu SEGAWA et al

Art Unit:

S. N.

Examiner:

International S.N.: PCT/JP01/01446

Filed: October 25, 2001

International Filing Date: 27 February 2001

For: METHOD OF PRODUCING PHASE MASK FOR

PROCESSING OPTICAL FIBER AND OPTICAL FIBER WITH BRAGG DIFFRACTION GRATING

FABRICATED BY USING THE OPTICAL

FIBER-PROCESSING PHASE MASK

RECEIVED

TC 1700

INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents Washington, D.C. 20231

Sir:

Applicants wish to draw attention to the documents EisFed on the accompanying Form PTO-1449, copies of which documents are enclosed.

The documents were cited in the counterpart PCT patent application, and a copy of the International Search Report (Form PCT/ISA/210 (second sheet)) is enclosed.

Pursuant to MPEP 609 A(3), it is believed that the first indication of relevance of the non-English documents give Find the International Search Report satisfies the requirement in 37 CFR 1.98(a)(3) for a concise explanation of relevance with respect to these non-English documents.

Pursuant to MPEP 609, it is requested that the Examiner should initial Form PTO-1449 to confirm that each document has been considered, and return a copy of the form to the undersigned.

Respectfully submitted,

Reg. No.

802 DELLETT AND WALTERS Suite 1101 310 S.W. Fourth Avenue Portland, Oregon 97204 US (503) 224-0115 DOCKET: A-413

Certificate of Mailing

I hereby certify that this correspondence is being deposited as first class mail with the United States Postal Service in an envelope addressed to the Assistant Commissioner for Patents, Washington, D.C. 20231, on this day of , 2002.

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